


<b>Search Notes</b>  	<b>Application/Control No.</b>  10585766	<b>Applicant(s)/Patent Under Reexamination</b>  ONISHI ET AL.
	<b>Examiner</b>  Emmanuel S Luk	<b>Art Unit</b>  1791

SEARCHED			
Class	Subclass	Date	Examiner
425	149, 150, 582, 583	8/3/08	EL
366	78	8/3/08	EL

SEARCH NOTES		
Search Notes	Date	Examiner
EAST text search	8/3/08	EL
Reviewed PCT/JP04/19409, parent PCT case at WIPO website along with translated documents	8/3/08	EL
inventor search	8/3/08	EL
updated search	2/13/09	EL
consulted Joe Del Sole AU 1791	2/13/09	EL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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